PATENT ABSTRACTS OF JAPAN

(11)Publication number:

2000-021789

(43)Date of publication of application: 21.01.2000

(51)Int.CI.

H01L 21/205 H01L 33/00 H01S 5/323

(21)Application number: 10-256088

(22)Date of filing:

27.08.1998

(71)Applicant:

TOSHIBA CORP

(72)Inventor:

SUGIURA RISA

ISHIKAWA MASAYUKI **NUNOGAMI SHINYA** ONOMURA MASAAKI YAMAMOTO MASAHIRO

(30)Priority

Priority number: 09234884

10050773

Priority date: 29.08.1997

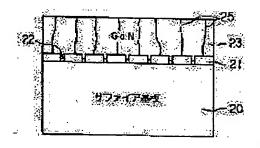
03.03.1998

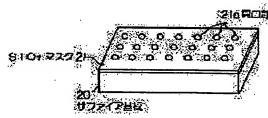
Priority country: JP

JP

(54) NITRIDE SEMICONDUCTOR ELEMENT, LIGHT EMITTING ELEMENT AND THEIR MANUFACTURE

PROBLEM TO BE SOLVED: To reduce the crystal defect density of dislocations, laminate defects, defective tubular holes, etc., by forming a desired element structure on a nitride compd. semiconductor layer involving a first region having vertically extending through-dislocations and second region released from the dislocation, other than the center part. SOLUTION: On a sapphire substrate 20, an SiO2 mask 21 having openings 21a of 2 μm in diameter at spacings of 10 μm is formed, the sapphire substrate 20 with the mask 21 is introduced in a region chamber of an MCVD apparatus, then thermally cleaning is made to remove moisture and natural oxide film, a GaN buffer layer 22 is formed on the sapphire substrate 20 with the mask 21, and the substrate temp. is raised after growing the buffer layer 22 to form a GaN layer 23. From the sectional TEM observation, the through-dislocations 25 locate only approximately at a central part of the SiO2 mask 21 and the crystal defect little exists at other parts.





LEGAL STATUS

[Date of request for examination]

07.03.2001

[Date of sending the examiner's decision of rejection]

[Kind of final disposal of application other than the examiner's decision of rejection or application converted registration]

[Date of final disposal for application]

[Patent number]

[Date of registration]

[Number of appeal against examiner's decision of rejection]

[Date of requesting appeal against examiner's decision of rejection]

[Date of extinction of right]